Search Notes



| Application/Control No. | Applicant(s)/Patent Under Reexamination |
|-------------------------|---|
| 10541454 | YOSHIMURA ET AL. |
| Examiner | Art Unit |

1792

| SEARCHED | | | | | | |
|----------|--------------|---------|----------|--|--|--|
| Class | Subclass | Date | Examiner | | | |
| 427 | 127, 131,132 | 12-1-08 | ab | | | |
| 428 | 323, 570 | 12-1-08 | ab | | | |

Alain L Bashore

| SEARCH NOTES | | | | |
|---------------------------------|-----------|----------|--|--|
| Search Notes | Date | Examiner | | |
| EAST (attached) | 12-1-08 | ab | | |
| eDan inventor search | 12-1-08 | ab | | |
| previous search updated | 6-8-09 | ab | | |
| inventor, EAST search (updated) | 1/26/2010 | ML | | |

| INTERFERENCE SEARCH | | | | | |
|---------------------|----------|------|----------|--|--|
| Class | Subclass | Date | Examiner | | |

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U.S. Patent and Trademark Office Part of Paper No.: 20100127